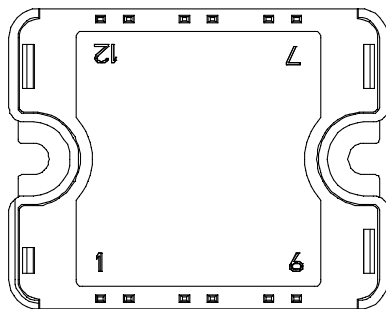
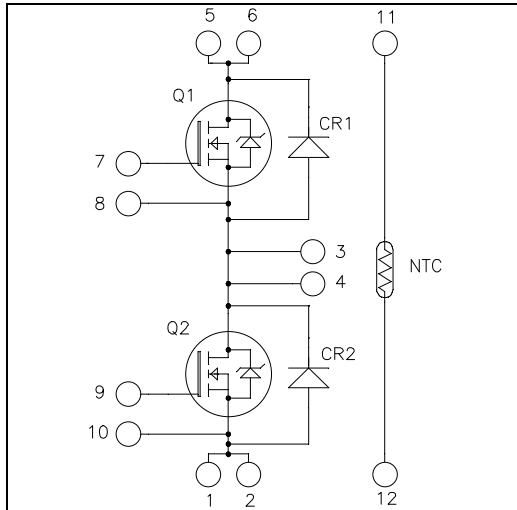


**Phase leg  
SiC MOSFET Power Module**

**$V_{DSS} = 1200V$**   
 **$R_{DS(on)} = 17m\Omega \text{ max @ } T_j = 25^\circ C$**   
 **$I_D = 143A \text{ @ } T_c = 25^\circ C$**



Pins 1/2 ; 3/4 ; 5/6 must be shorted together

### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

### Features

- **SiC Power MOSFET**
  - Low  $R_{DS(on)}$
  - High temperature performance
- **SiC Schottky Diode**
  - Zero reverse recovery
  - Zero forward recovery
  - Temperature Independent switching behavior
  - Positive temperature coefficient on VF
- Very low stray inductance
- Internal thermistor for temperature monitoring
- High level of integration
- AlN substrate for improved thermal performance

### Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

**All ratings @  $T_j = 25^\circ C$  unless otherwise specified**

### 1. SiC MOSFET characteristics (Per MOSFET)

Symbol	Parameter	Max ratings	Unit
$V_{DSS}$	Drain - Source Breakdown Voltage	1200	V
$I_D$	Continuous Drain Current	$T_c = 25^\circ C$	143
		$T_c = 80^\circ C$	108
$I_{DM}$	Pulsed Drain current	280	A
$V_{GS}$	Gate - Source Voltage	-10/+25	V
$R_{DS(on)}$	Drain - Source ON Resistance	17	$m\Omega$
$P_D$	Maximum Power Dissipation	$T_c = 25^\circ C$	600
			W

**CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.  
 See application note APT0502 on [www.microsemi.com](http://www.microsemi.com)

**Electrical Characteristics**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 1200V		20	200	μA
R <sub>DS(on)</sub>	Drain – Source on Resistance	V <sub>GS</sub> = 20V I <sub>D</sub> = 100A		12.5 22	17 32	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 2mA	1.9	2.3		V
I <sub>GSS</sub>	Gate – Source Leakage Current	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0V			1	μA

**Dynamic Characteristics**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> = 0V		5960		pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 1000V		440		
C <sub>rss</sub>	Reverse Transfer Capacitance	f = 1MHz		46		
Q <sub>g</sub>	Total gate Charge	V <sub>GS</sub> = -2/+20V		360		nC
Q <sub>gs</sub>	Gate – Source Charge	V <sub>Bus</sub> = 800V		64		
Q <sub>gd</sub>	Gate – Drain Charge	I <sub>D</sub> = 100A		126		
T <sub>d(on)</sub>	Turn-on Delay Time	V <sub>GS</sub> = -2/+20V		21		ns
T <sub>r</sub>	Rise Time	V <sub>Bus</sub> = 800V		19		
T <sub>d(off)</sub>	Turn-off Delay Time	I <sub>D</sub> = 100A		50		
T <sub>f</sub>	Fall Time	R <sub>L</sub> = 8Ω ; R <sub>G</sub> = 10Ω		30		
E <sub>on</sub>	Turn on Energy	Inductive Switching V <sub>GS</sub> = -5/+20V V <sub>Bus</sub> = 600V		2.2		mJ
E <sub>off</sub>	Turn off Energy	I <sub>D</sub> = 100A R <sub>G</sub> = 10Ω		1.2		
R <sub>thJC</sub>	Junction to Case Thermal Resistance				0.21	°C/W

**2. SiC diode characteristics (Per SiC diode)**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage		1200			V
I <sub>RM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> = 1200V		70 130	400 800	μA
I <sub>F</sub>	DC Forward Current			40		A
V <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> = 40A		1.5 2.2	1.8 3	V
Q <sub>C</sub>	Total Capacitive Charge	I <sub>F</sub> = 40A, V <sub>R</sub> = 1200V di/dt = 1000A/μs		260		nC
C	Total Capacitance	f = 1MHz, V <sub>R</sub> = 200V		186		pF
		f = 1MHz, V <sub>R</sub> = 400V		134		
R <sub>thJC</sub>	Junction to Case Thermal Resistance				0.7	°C/W

### 3. Thermal and package characteristics

#### Package characteristics

Symbol	Characteristic	Min	Typ	Max	Unit	
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz	4000			V	
T <sub>J</sub>	Operating junction temperature range	SiC MOSFET	-40	150	°C	
		SiC diode	-40	175		
T <sub>JOP</sub>	Recommended junction temperature under switching conditions	-40		T <sub>J,max</sub> -25		
T <sub>STG</sub>	Storage Temperature Range	-40		125		
T <sub>C</sub>	Operating Case Temperature	-40		125		
Torque	Mounting torque	To heatsink	M4	2	3	N.m
Wt	Package Weight				80	g

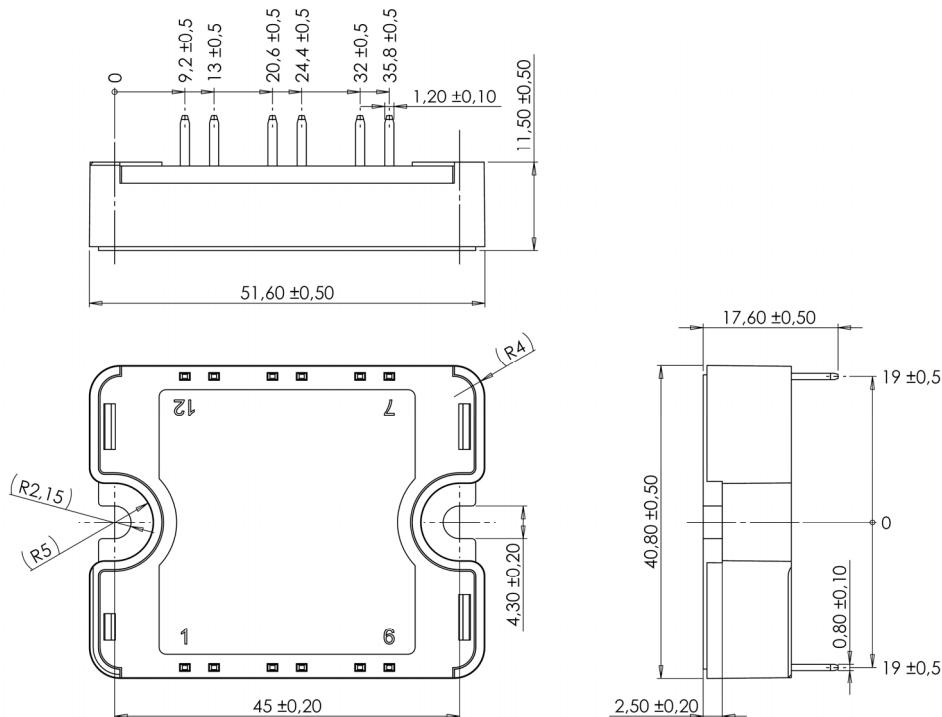
#### Temperature sensor NTC (see application note APT0406 on www.microsemi.com).

Symbol	Characteristic	Min	Typ	Max	Unit
R <sub>25</sub>	Resistance @ 25°C		50		kΩ
ΔR <sub>25</sub> /R <sub>25</sub>			5		%
B <sub>25/85</sub>	T <sub>25</sub> = 298.15 K		3952		K
ΔB/B	T <sub>C</sub> = 100°C		4		%

$$R_T = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$

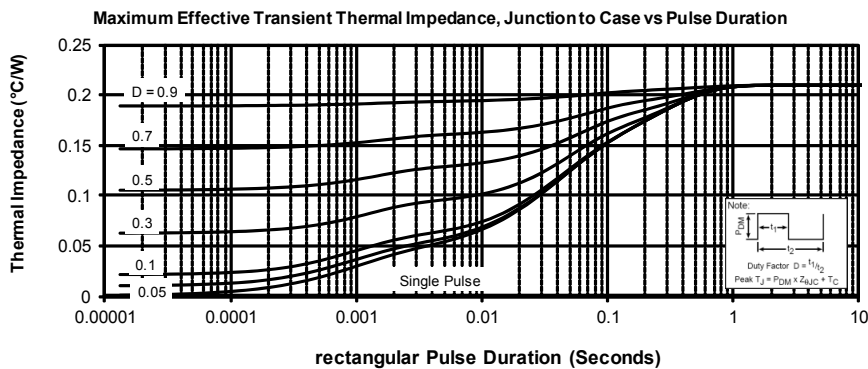
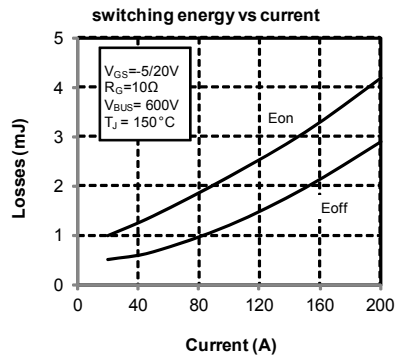
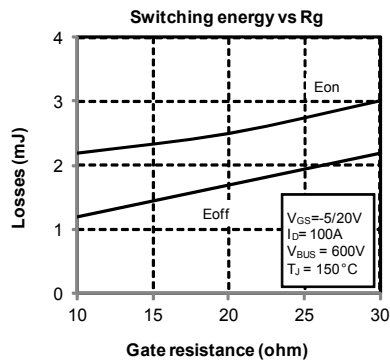
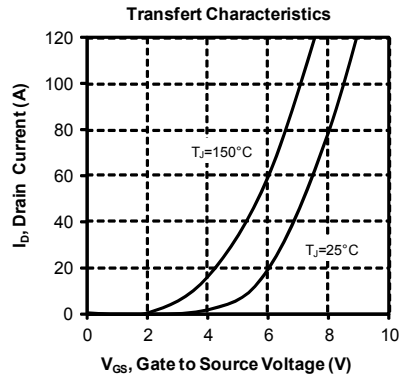
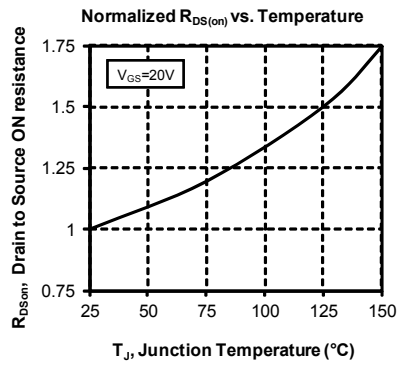
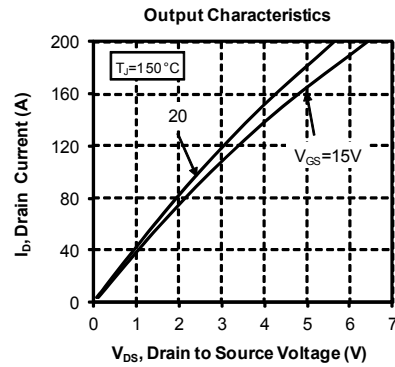
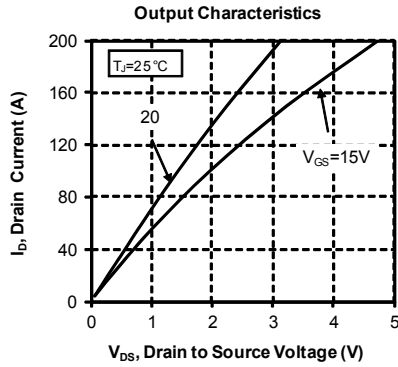
T: Thermistor temperature  
 R<sub>T</sub>: Thermistor value at T

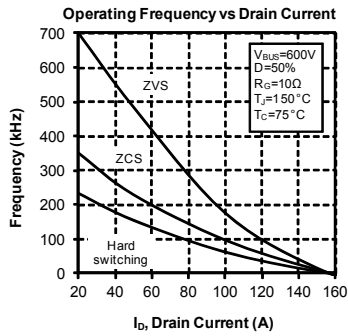
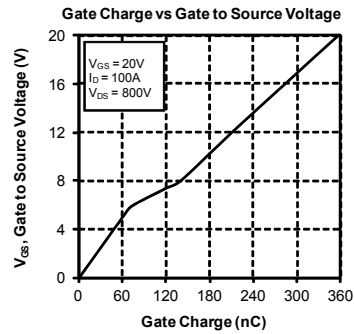
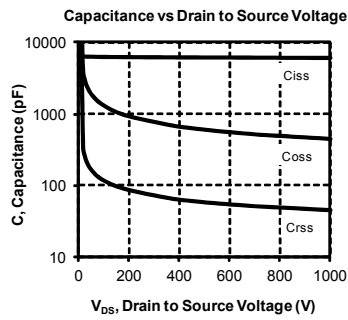
#### SP1 Package outline (dimensions in mm)



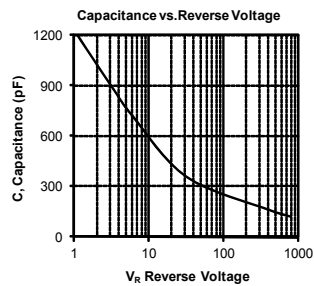
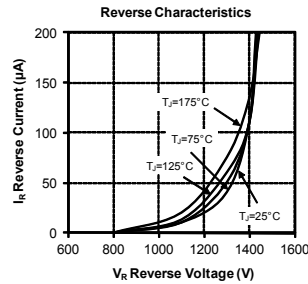
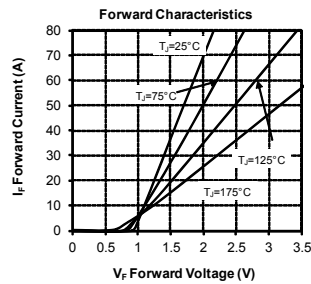
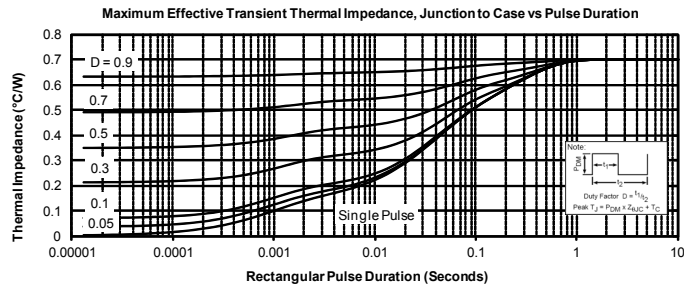
See application note 1904 - Mounting Instructions for SP1 Power Modules on www.microsemi.com

## 4. Typical Performance Curves SiC MOSFET





## SiC diode



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